A sample filter holder for use with a microscope for holding the filter in a planar condition on the stage of the microscope so that automatic focusing of the microscope can be performed on particle samples dispersed on the filter. The holder includes a base having a well communicating with an inlet port which is connected to a suction pump. A screen assembly is positioned within the well. The screen assembly includes a disk having a screen positioned on its top surface and secured to the disk at the peripheral edge of the screen. Small bores communicate the outer surface of the screen with the well. The filter is placed on the screen and is held in a flat disposition by the suction forces.
SAMPLE HOLDER SUPPORT FOR MICROSCOPES

ORIGIN OF THE INVENTION

The invention described herein was made by employees of the United States Government and may be manufactured and used by or for the Government for Government purposes without the payment of any royalties thereon or therefor.

BACKGROUND OF THE INVENTION

This invention relates to microscope sample holder supports and more particularly to a support for holding the filter pad on which particulate is to be viewed and focused through a programmed microscope to permit automatic focusing of the particles for analysis and counting.

In the art of microscopic particle analysis the particulate is deposited on a very thin filter pad in the form of a disk or wafer which is placed on a support at the microscope stage and held in place by mechanical rings which are positioned on the edge of the filter pad. Thus, the only portion of the filter pad that is held and maintained flat is the edge of the filter pad. State of the art high quality microscopes used as an image analyzer for particle counting can be programmed to move in three planes and has a limited depth of field automatic focusing capability in the Z-plane. When the microscope focuses on or “sees” a particle, it displays it on a screen where the size and number of particles can be made automatically. However, because of the limited depth of field of the automatic focusing features, if the filter pad on which the particles are carried is not planar, the microscope will not focus properly and thus will not see nor count the particles outside of its depth of field. Because the filter pads of the prior art were merely maintained flat at the peripheral edge, with the edge in focus, substantial portions of the remainder of the filter pads which are outside the focusing range could not be maintained. It has therefore been the practice in the prior art to manually focus the microscope in the Z-plane and manually refocus after the microscope has moved to a different point in the X-Y plane.

SUMMARY OF THE INVENTION

Consequently, it is a primary object of the present invention to provide a filter pad holder for use with a microscope to permit particle analysis to be performed automatically, the particles being dispersed on the filter pad.

It is another object of the present invention to provide a sample holder for microscopes that permit a filter pad on which the samples are dispersed to be held planar so that focusing of the microscope on the samples may be readily performed.

It is a further object of the present invention to provide holding apparatus for supporting a filter pad carrying particles for analysis in a planar disposition for use in a microscope having automatic focusing features used for particle analysis, the apparatus comprising a base carrying a planar screen or plate having apertures on which the filter pad is disposed, the base having means for communicating the screen with a source of sub-atmospheric pressure so that the filter pad is drawn against the screen.

Accordingly, the present invention provides holding apparatus for supporting a sample carrying filter pad in a planar condition on the stage of a microscope, the holding apparatus having a base member adapted to be positioned on the stage and having an inlet port communicating with a well within the base, the well opening at the top of the base for receiving a screen assembly having a planar screen surface which is positioned about the opening of the top. The filter pad is disposed on the screen assembly and the inlet port of the base is connected to a source of sub-atmospheric pressure to draw a suction at the screen and thus the filter pad. The screen includes a plurality of spaced apart apertures so that the suction force on the filter is substantially equally applied across the surface of the filter to draw it against the planar surface of the screen. The filter is thereby maintained flat about its entire surface and the samples carried on the filter are thus in a substantially planar disposition for focusing upon by the microscope for analysis and counting without the need for refocusing at different locations across the filter.

BRIEF DESCRIPTION OF THE DRAWINGS

The particular features and advantages of the invention as well as other objects will become apparent from the following description taken in connection with the accompanying drawings, in which:

FIG. 1 is a perspective view of a microscope including sample holding apparatus constructed in accordance with the principles of the present invention;

FIG. 2 is a perspective view of the sample holding apparatus illustrated in FIG. 1 at a greatly enlarged scale;

FIG. 3 is a vertical cross sectional view taken through the apparatus of FIG. 2 with the coupling removed;

FIG. 4 is a top plan view of the screen assembly of the holding apparatus removed from the base; and

FIG. 5 is an elevational view of the screen assembly.

DESCRIPTION OF THE PREFERRED EMBODIMENT

Referring now to the drawings, FIG. 1 illustrates a microscope 10 which preferably may be of the type which is program driven to move the stage 12 in three planes and can automatically focus in the Z-plane. The microscope per se does not form any part of the present invention and the details thereof are not deemed necessary to the disclosure of the holding apparatus of the present invention, the holding apparatus being generally indicated at 14. The samples, i.e., the particles to be analyzed and counted are disposed conventionally on a filter pad which is a thin disk in the order of 30 microns, the filter pad being constructed of selected material such as acetate, teflon, paper, polyester or other material which is compatible with the liquid solvent in which the particles are suspended so that the liquid may flow through the filter and leave the particles dispersed thereon for sample analysis. As aforesaid, when performing sample analysis and particle counting, unless the particles are disposed in a flat or planar disposition the automatic focusing feature of the microscope is not effective because of the limited depth of field for automatic focus. In the prior art the filter pad holders were annular rings which only held the filter pad flat about the peripheral edge of the filter so that the automatic focusing capability could not be performed and focusing had to be done manually.
To overcome this problem of the prior art, the holding apparatus of the present invention provides a base in the form of a block which may be constructed of any convenient material such as stainless steel, the base having an inlet port which may be threaded internally for receiving a fluid coupling. The inlet port communicates through a channel to an annular cavity centrally disposed in the base and which opens onto a well which in turn opens onto and is recessed below a counterbored opening in the upper surface of the base. Thus, the well is in flow communication with the coupling. As illustrated in FIG. 1, the coupling is connected to a conduit which in turn is connected to a vacuum pump for drawing a sub-atmospheric pressure or vacuum in the well.

Positioned in the counterbore and resting on a ledge at the junction between the counterbore and a conically tapered wall of the well is a screen assembly, the screen assembly comprising a disk having a diameter adapted to be received within the counterbore and having a thickness so that when positioned on the ledge it is disposed slightly below the surface of the base. A thin wafer of fine screening material such as a 0.010 inch thick screen having pore diameters of approximately 0.0039 inch is fastened about its periphery to the upper surface of the disk coaxial with the disk, the screen having a smaller peripheral diameter than the disk. Both the disk and the screen wafer may be of stainless steel and the periphery of the wafer may be silver soldered to the disk. Concentric with the disk at the surface remote from the screen is a small diameter hub which extends therefrom and is received within the well coaxial with the cavity. The outside diameter of the hub, which is approximately 0.3 inch is slightly smaller than the diameter of the cavity so that there is a small space between the hub and the wall of the cavity. Formed through the screen and the disk are a plurality of spaced apart bores which are being illustrated including one which extends through the hub and the others being equally divided along two radially spaced apart locations. The diameter of the bores which preferably are formed by drilling is approximately 0.06 inch and all but the one in the hub communicates with the well, the bore in the hub communicating directly with the cavity.

In use, a filter pad is placed on the upper surface of the screen assembly with substantially the major portion of the filter disposed on the screen wafer. A vacuum is then drawn by the pump and the vacuum communicates through the bores and the vacuum being leaked between the screen wafer and the surface of the disk so that a substantially equalized sub-atmospheric pressure is applied to the underside of the filter through the tiny pores of the screen. Since the screen is planar, the filter is pulled into a substantially planar disposition so that when the microscope is focused on a particle disposed on the filter, the remaining particles will be within the depth of the field capabilities for the automatic focusing features of the microscope thereby overcoming the difficulties encountered in the prior art.

Numerous alterations of the structure herein disclosed will suggest themselves to those skilled in the art. However, it is to be understood that the present disclosure relates to the preferred embodiment of the invention which is for purposes of illustration only and not to be construed as a limitation of the invention. All such modifications which do not depart from the spirit of the invention are intended to be included within the scope of the appended claims.

Having thus set forth the nature of the invention, what is claimed herein is:

1. A sample holder for use with a microscope so that the filter can be maintained in a substantially flat disposition, said holder comprising a base having a well formed therein, an inlet port communicating with said well, a screen assembly having a substantially planar filter support surface positioned in said well with said surface disposed for receiving a filter thereon, said assembly including flow passage means communicating said surface with said well, and means for connecting said inlet port to a source of suction for drawing said filter against said surface.

2. A filter holder as recited in claim 1, wherein said flow passage means comprises bores extending through said screen assembly and communicating with said well.

3. A filter holder as recited in claim 1, wherein said base has an upper surface, a peripheral ledge formed in said well recessed below said upper surface, said screen assembly including a disk positioned on said ledge, and a hub disposed in said well.

4. A filter holder as recited in claim 3, wherein said assembly includes a screen having a peripheral edge, said screen being disposed on said disk and secured thereto at said peripheral edge.

5. A filter holder as recited in claim 4, wherein said flow passage means comprises bores extending through said screen and said disk and communicating with said well.

6. A filter holder as recited in claim 5, wherein said flow passage means further comprises at least one bore extending through said hub.

7. In combination with a microscope for analyzing samples dispersed on a filter at the stage of the microscope, a holder for supporting said filter in a substantially planar disposition, said holder comprising a base having a well formed therein, an inlet port communicating with said well, a screen assembly having a substantially planar filter support surface positioned in said well with said surface disposed for receiving a filter thereon, said assembly including flow passage means communicating said surface with said well, and means for connecting said inlet port to a source of suction for drawing said filter against said surface.

8. The combination as recited in claim 7, wherein said flow passage means comprises bores extending through said screen assembly and communicating with said well.

9. The combination as recited in claim 7, wherein said base has an upper surface, a peripheral ledge formed in said well recessed below said upper surface, said screen assembly including a disk positioned on said ledge, and a hub disposed in said well.

10. The combination as recited in claim 9, wherein said assembly includes a screen having a peripheral edge, said screen being disposed on said disk and secured thereto at said peripheral edge.

11. The combination as recited in claim 10, wherein said flow passage means comprises bores extending through said screen and said disk and communicating with said well.

12. The combination as recited in claim 11, wherein said flow passage means further comprises at least one bore extending through said hub.